



POSITRON AND POSITRONIUM INTERACTIONS WITH CONDENSED MATTER

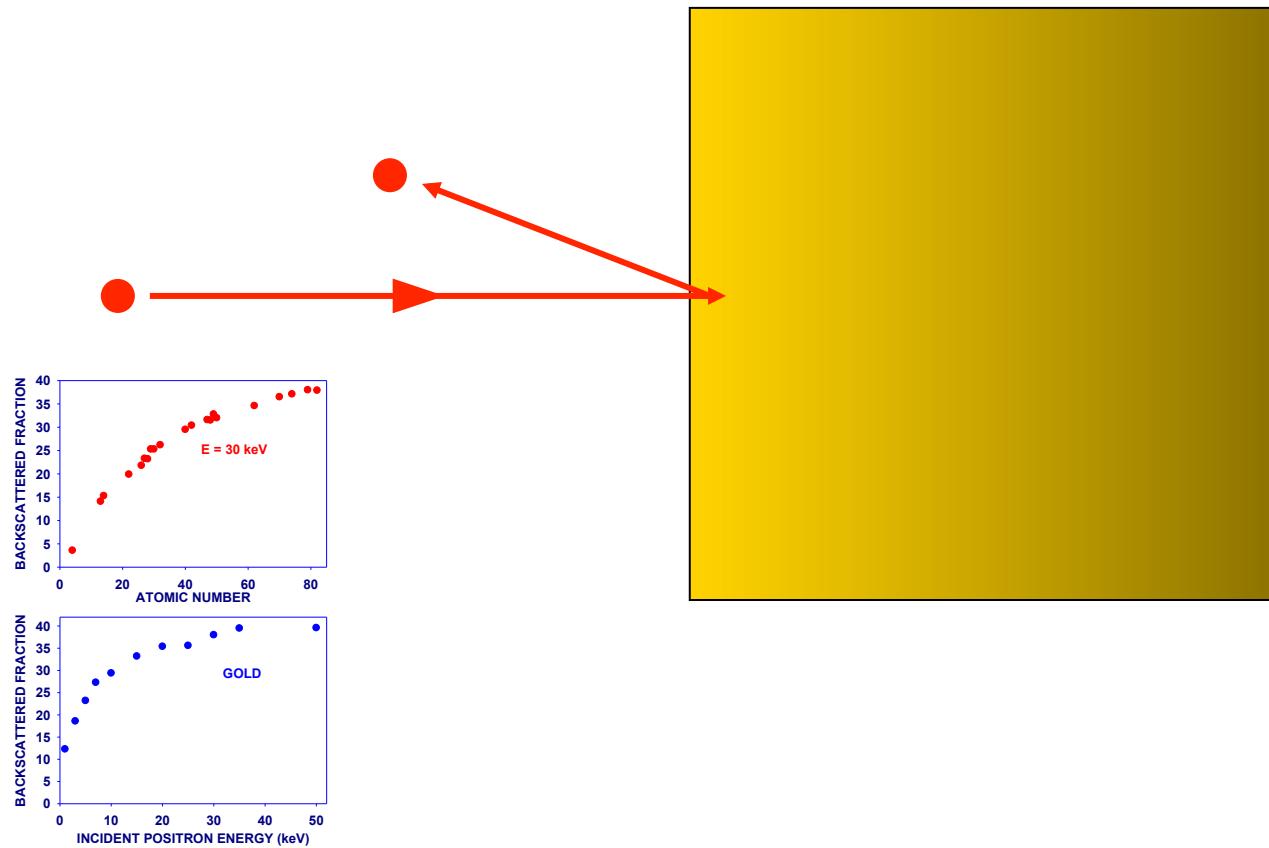
Paul Coleman
University of Bath



THE FATE OF POSITRONS IN CONDENSED MATTER POSITRON-SURFACE INTERACTIONS

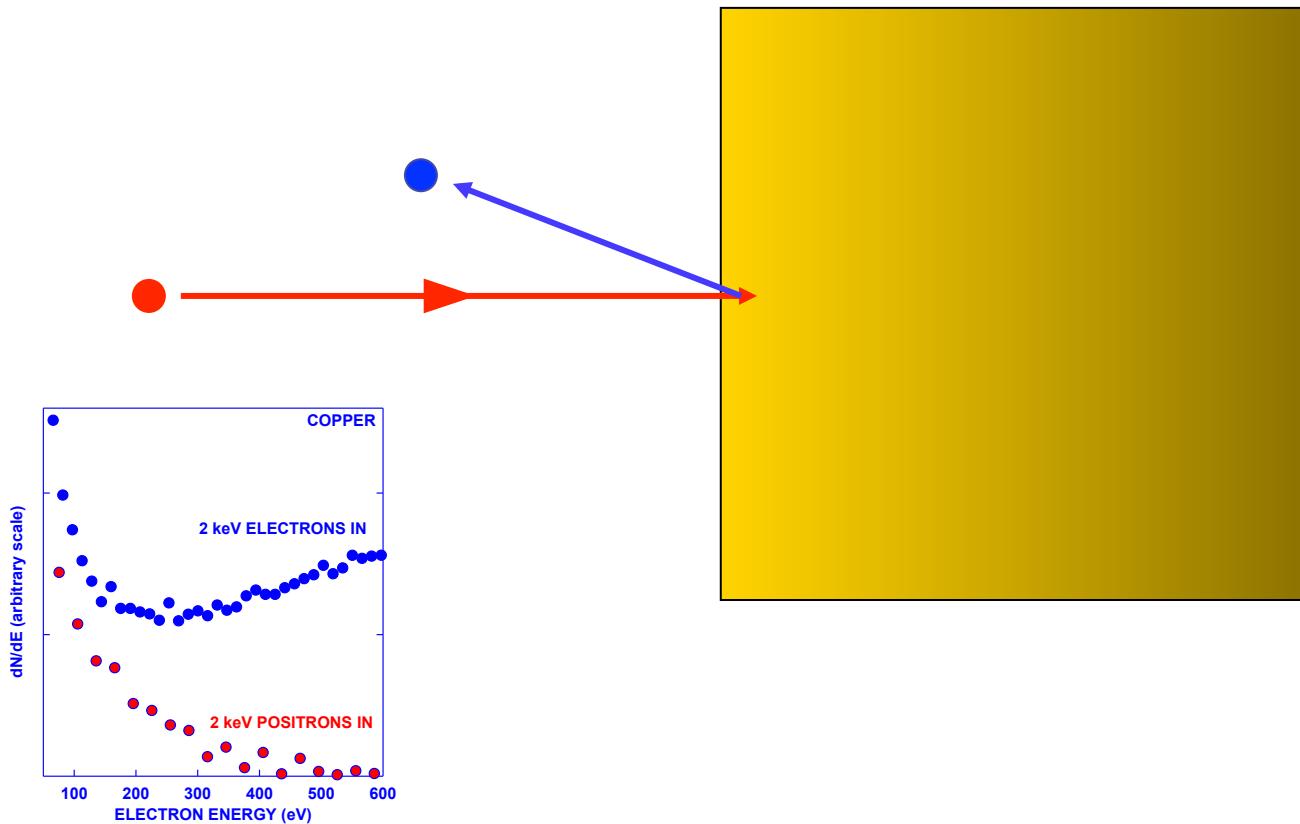


positron backscattering



THE FATE OF POSITRONS IN CONDENSED MATTER POSITRON-SURFACE INTERACTIONS

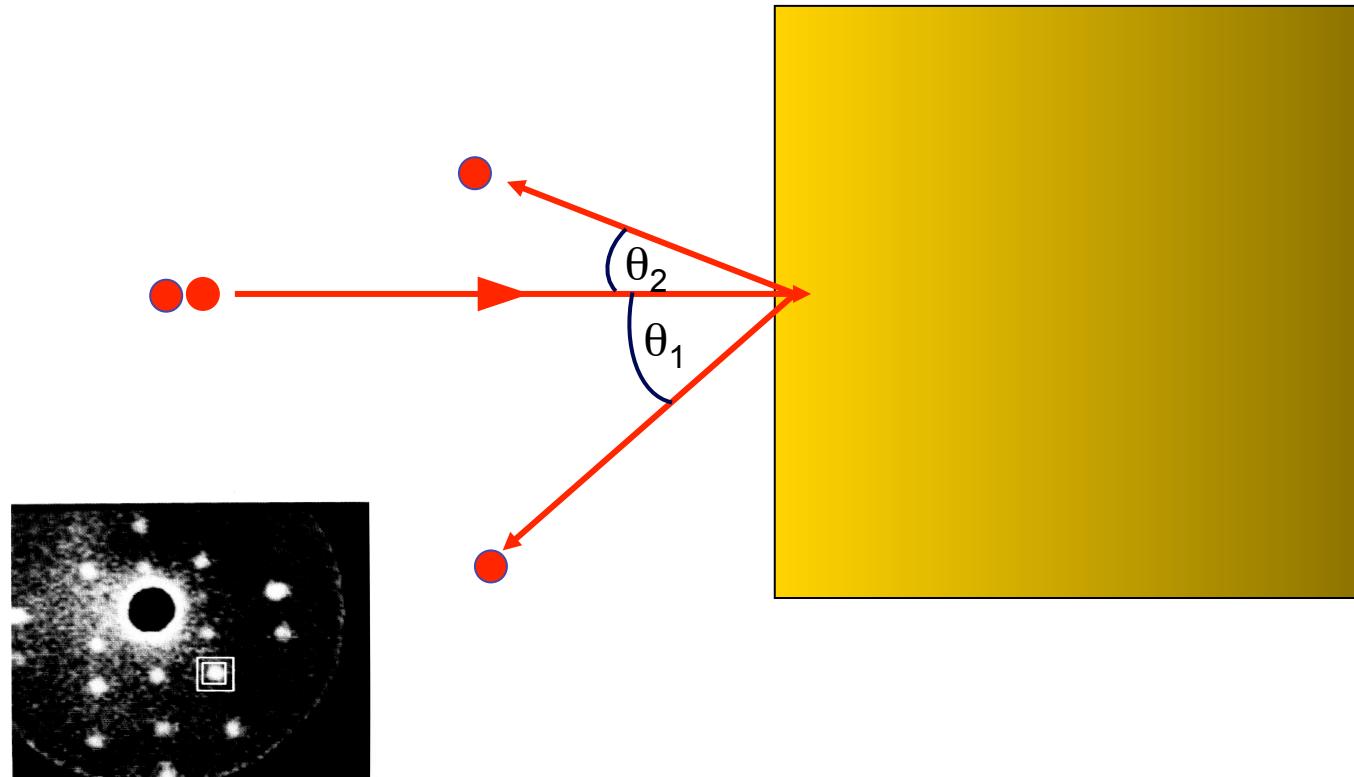
secondary electron emission



THE FATE OF POSITRONS IN CONDENSED MATTER POSITRON-SURFACE INTERACTIONS

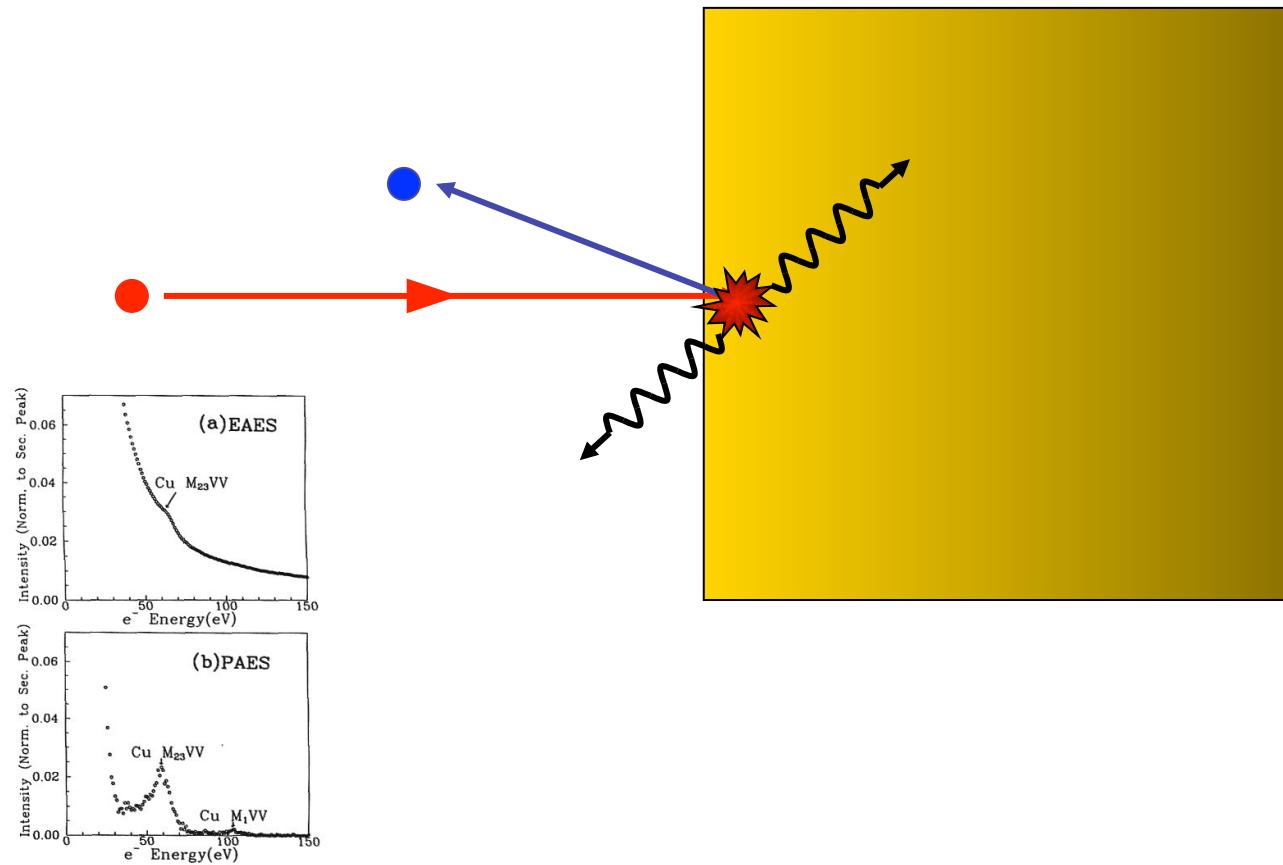


low-energy positron diffraction



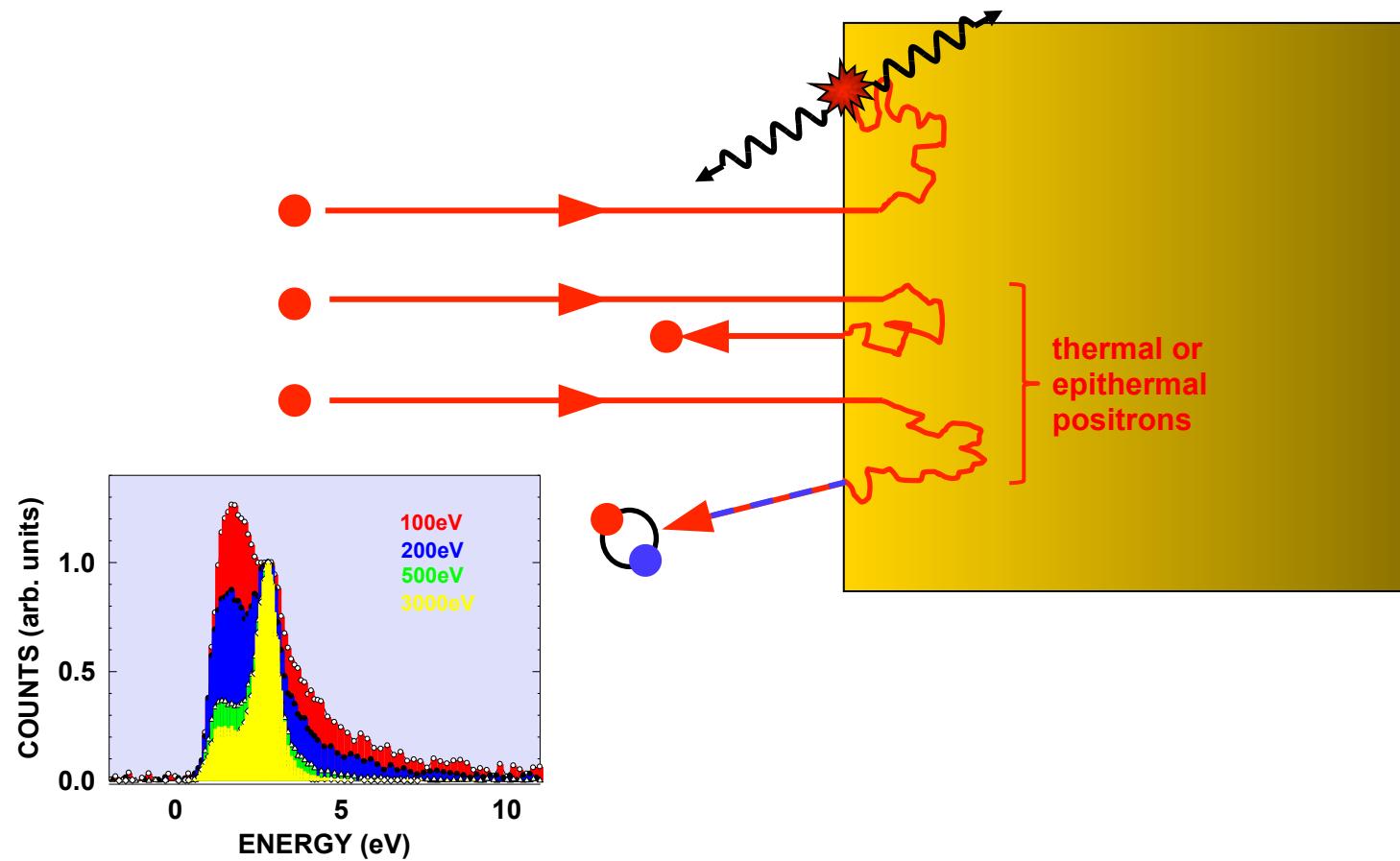
THE FATE OF POSITRONS IN CONDENSED MATTER POSITRON-SURFACE INTERACTIONS

Auger electron emission



THE FATE OF POSITRONS IN CONDENSED MATTER POSITRON-SURFACE INTERACTIONS

positron surface trapping, re-emission, positronium formation

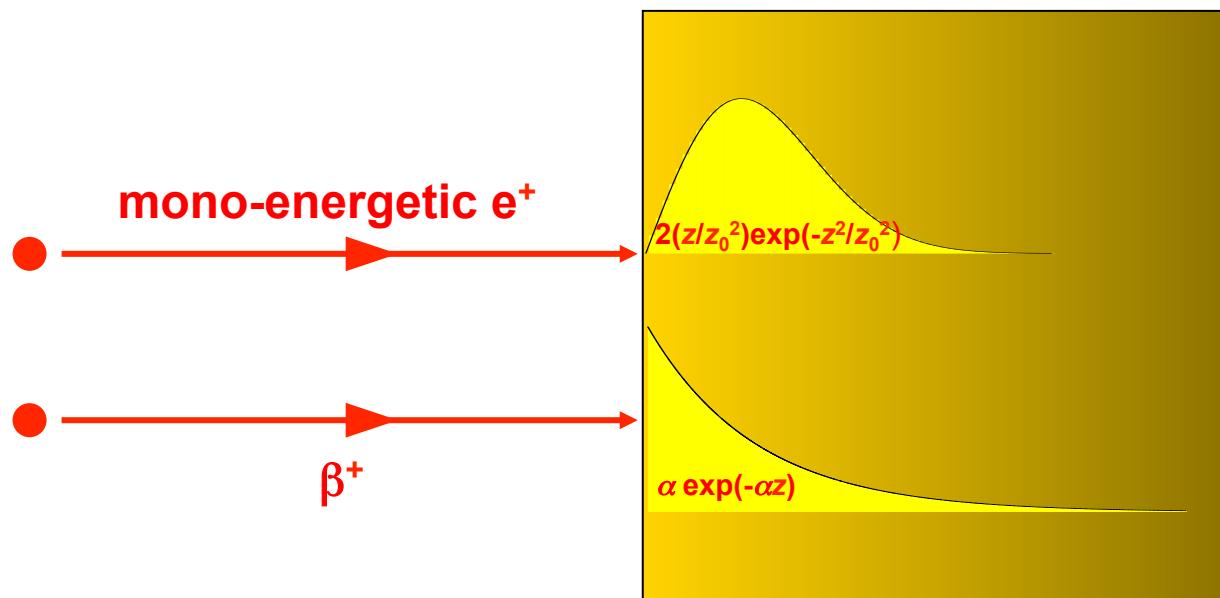


THE FATE OF POSITRONS IN CONDENSED MATTER

POSITRON-SOLID INTERACTIONS

positron implantation

depth distributions at thermalisation (after ~ps):



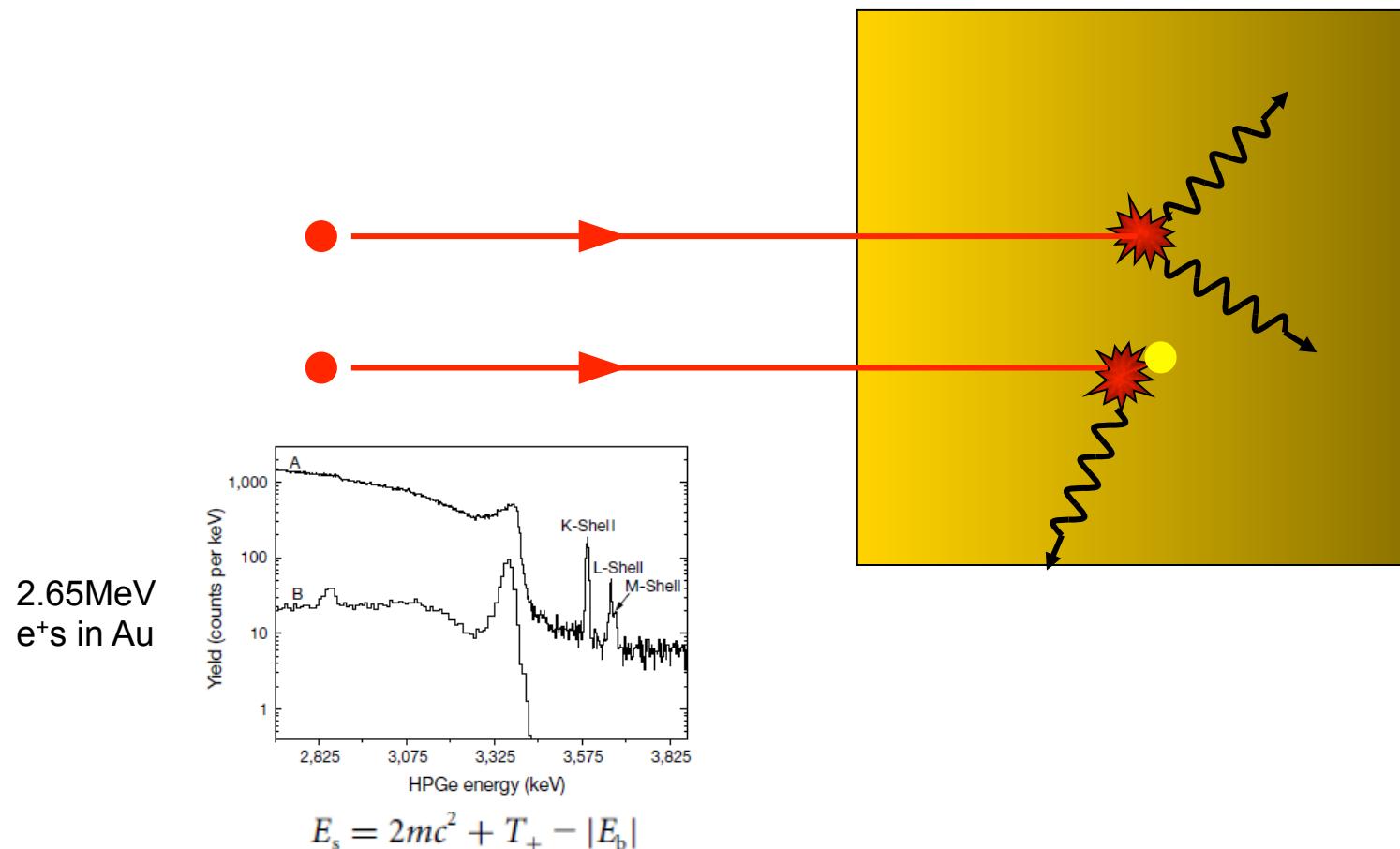
$P(z) = 2(z/z_0)^2 \exp(-z^2/z_0^2)$ where $z_0 = (40/\rho)E^{1.6}$ with density ρ in $g cm^{-3}$ and E in keV

$P(z) = \alpha \exp(-\alpha z)$, with α (cm) $\approx 16\rho E_m^{-1.4}$ (ρ = density in $g cm^{-3}$, E_m = maximum beta positron energy in keV)

THE FATE OF POSITRONS IN CONDENSED MATTER POSITRON-SOLID INTERACTIONS



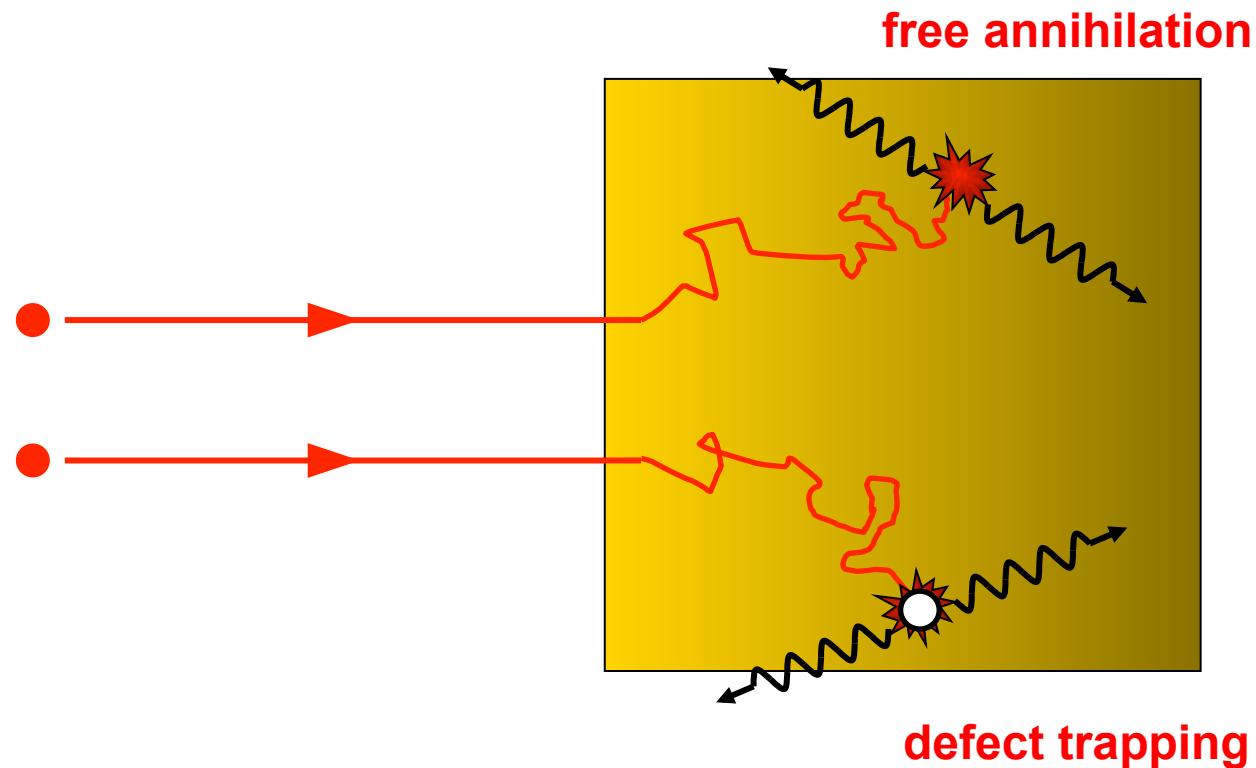
in-flight annihilation



THE FATE OF POSITRONS IN CONDENSED MATTER

POSITRON-SOLID INTERACTIONS

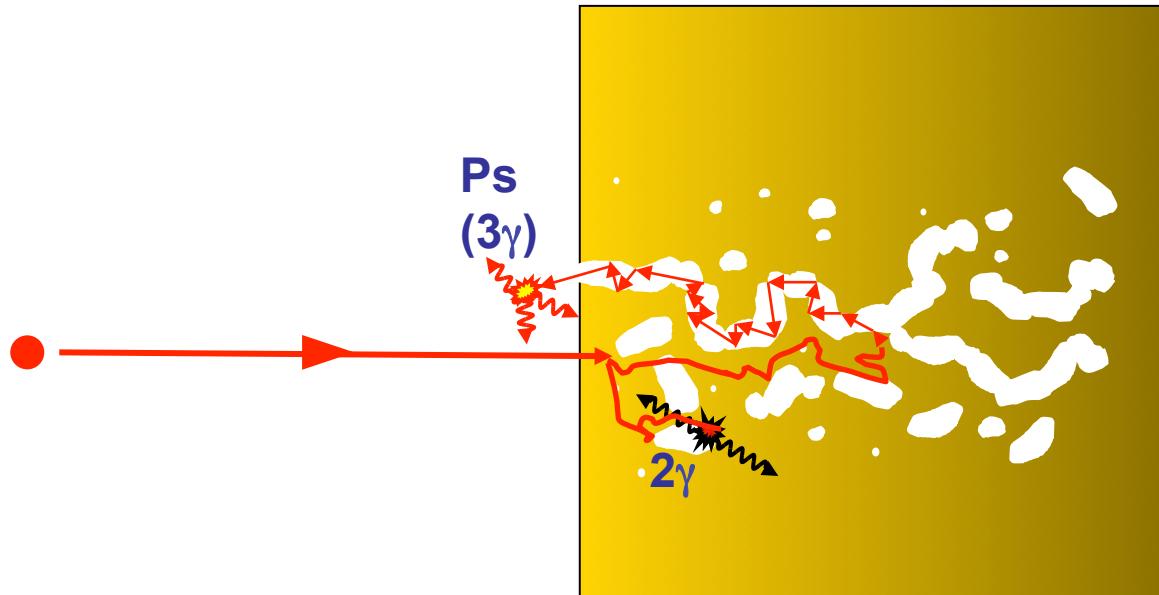
positron diffusion and annihilation



THE FATE OF POSITRONS IN CONDENSED MATTER

POSITRON-SOLID INTERACTIONS

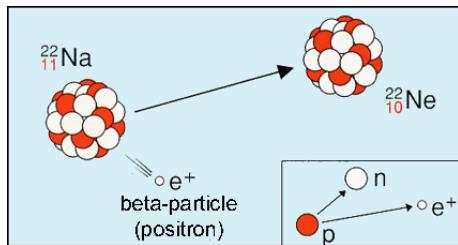
positronium formation – insulators, nanoporous materials



** see later talks in this session **

POSITRON SOURCES

RADIOACTIVE ISOTOPES – eg ^{22}Na



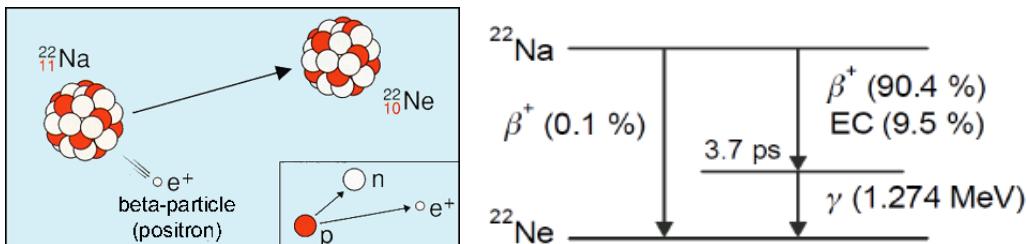
- Relatively long half-life (2.6 years)
- Relatively short biological half-life (3 days)
- 1.274 MeV γ can be used as a ‘start’ signal

The perennial problem – not enough positrons...



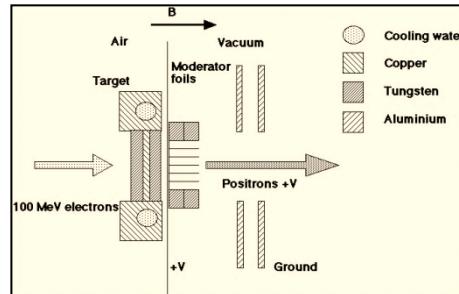
POSITRON SOURCES

RADIOACTIVE ISOTOPES – eg ^{22}Na



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LINEAR ACCELERATORS – eg KEK, Japan

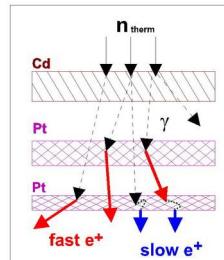


$\sim 10^2$ MeV electrons

bremstrahlung

pair production

RESEARCH REACTORS – eg NEPOMUC, Munich



n capture

gamma emission

pair production

POSITRON SPECTROSCopies

$$\rho(\mathbf{p})$$

= probability that a pair of annihilation gamma rays has total (ie $\sim e^-$) momentum \mathbf{p}

$$\rho(p_x, p_y) = \int \rho(\mathbf{p}) dp_z$$

2-D ANGULAR CORRELATION

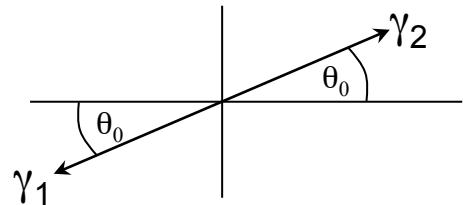
$$\rho(p_z) = \iint \rho(\mathbf{p}) dp_x dp_y$$

DOPPLER BROADENING SPECTROSCOPY

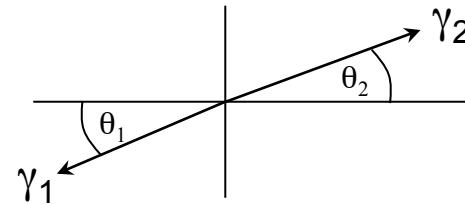
$$\lambda = \iiint \rho(\mathbf{p}) dp_x dp_y dp_z$$

LIFETIME SPECTROSCOPY

ANGULAR CORRELATION OF ANNIHILATION RADIATION



C of M FRAME

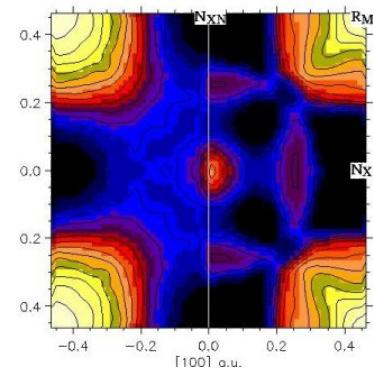
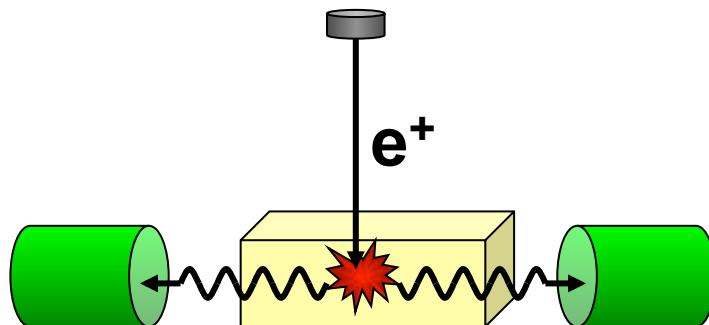


LAB FRAME

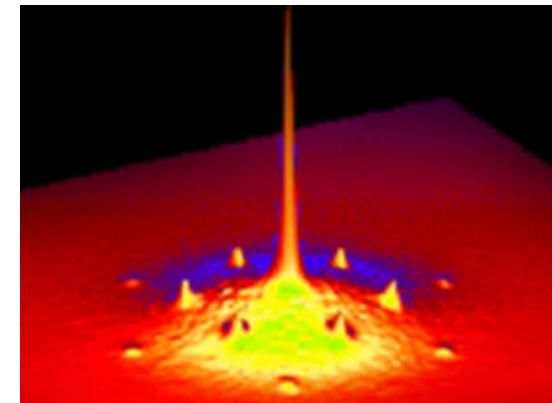
$$\delta\theta \approx p_t/mc \ (\sim 5-20 \text{ mrad})$$

where p_t is the component of momentum of the annihilating pair in a direction transverse to the gamma emission

→ **electron momentum densities**



Bristol 2D-ACAR lab



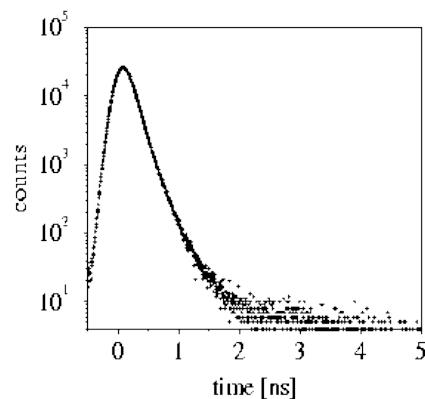
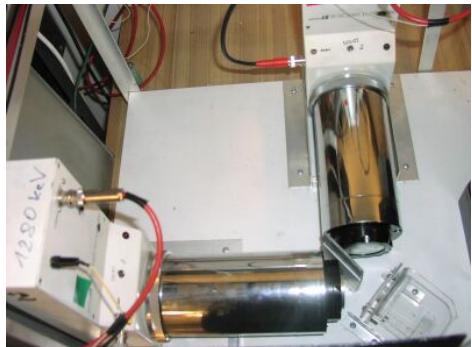
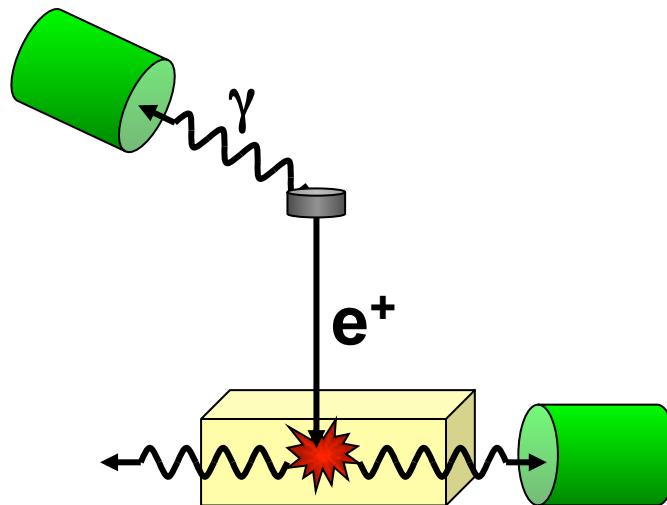
2D-ACAR – quartz ↑

← 2D Fermi surface

POSITRON LIFETIME SPECTROSCOPY

$$I(t) = \sum_i I_i \exp(-\lambda_i t)$$

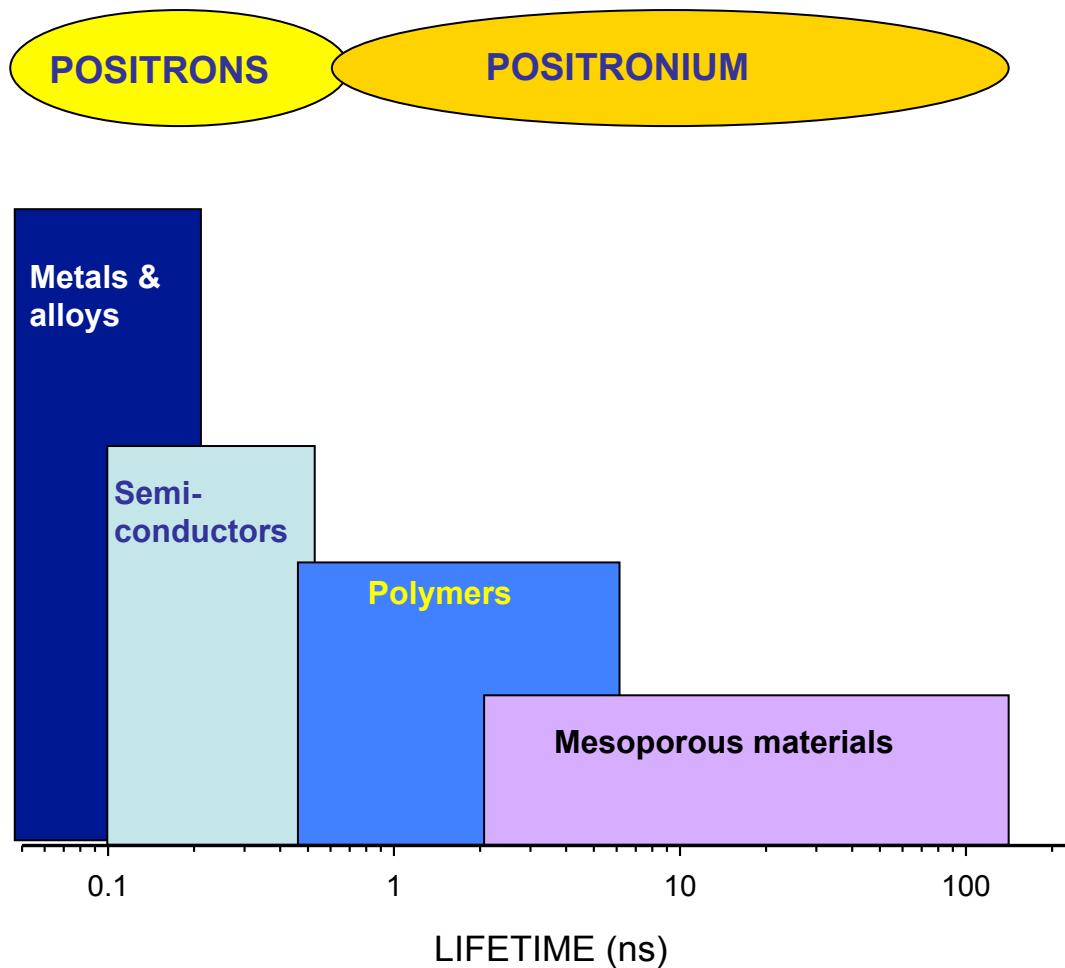
↓
**electron
densities**



positronium (Ps): $e^+ - e^-$ bound state

- formed in insulators
- para-Ps lives 125 ps in vacuum
- ortho-Ps lives 142 ns in vacuum
- typical Ps lifetime in solids ~ ns

POSITRON LIFETIME MEASUREMENT



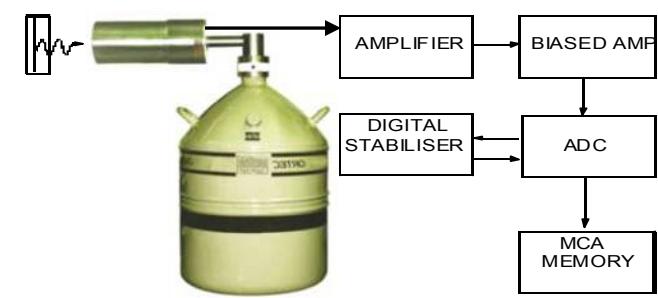
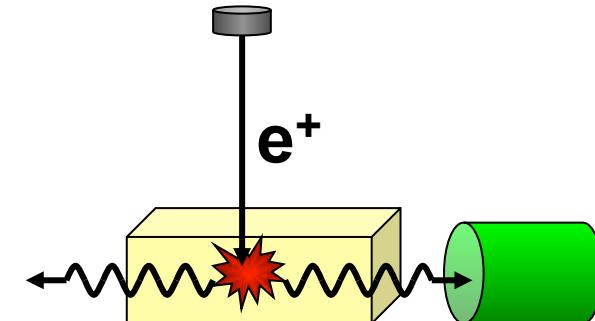
DOPPLER BROADENING SPECTROSCOPY

Doppler shift in the photon energy = $\pm cp_z/2$

If p_z is from a 5eV electron $cp_z/2 = 1130$ eV
 (\sim the resolution of a high-purity Ge detector)

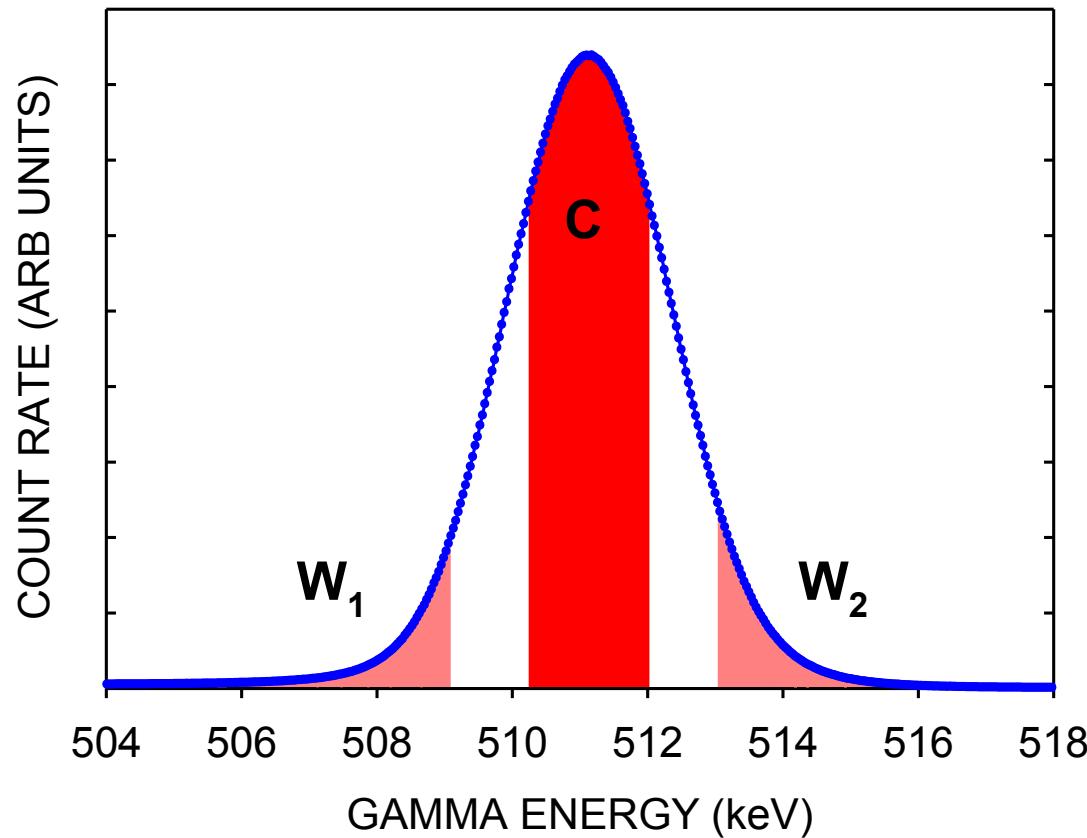
Doppler *broadening* around 511keV is measured

Good for rapid, low-resolution measurements of e^- momenta vs time, temperature etc.



DOPPLER BROADENING SPECTROSCOPY

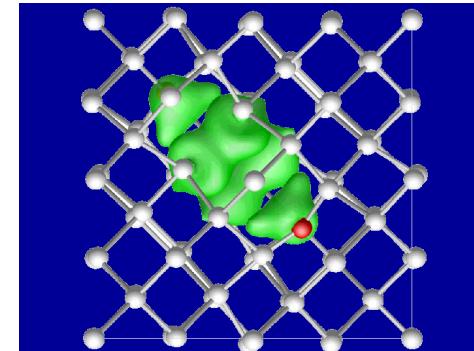
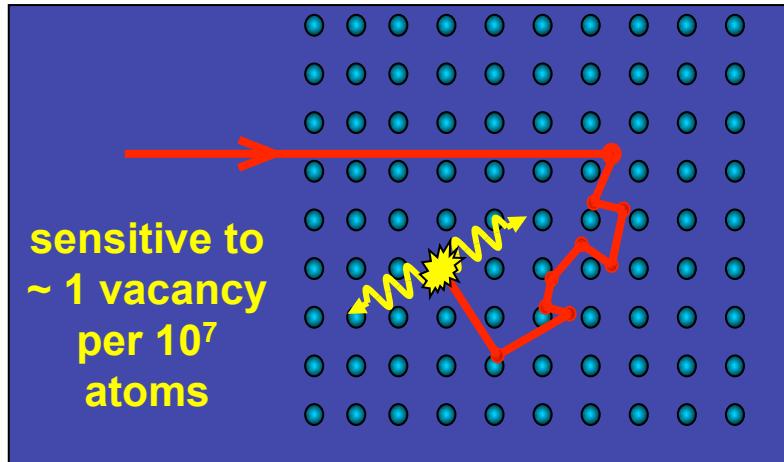
PARAMETERS:
Sharpness parameter $S = C/A$
Wing parameter $W = (W_1 + W_2)/A$
where A = total area under photopeak



WHAT CAN BE STUDIED?

OPEN-VOLUME POINT DEFECTS

VACANCIES, VACANCY CLUSTERS, DISLOCATIONS, GRAIN BOUNDARIES, INNER/OUTER SURFACES



TRANSITION LIMITED TRAPPING:

High C, deep but narrow traps: $K = \nu C$

DIFFUSION LIMITED TRAPPING:

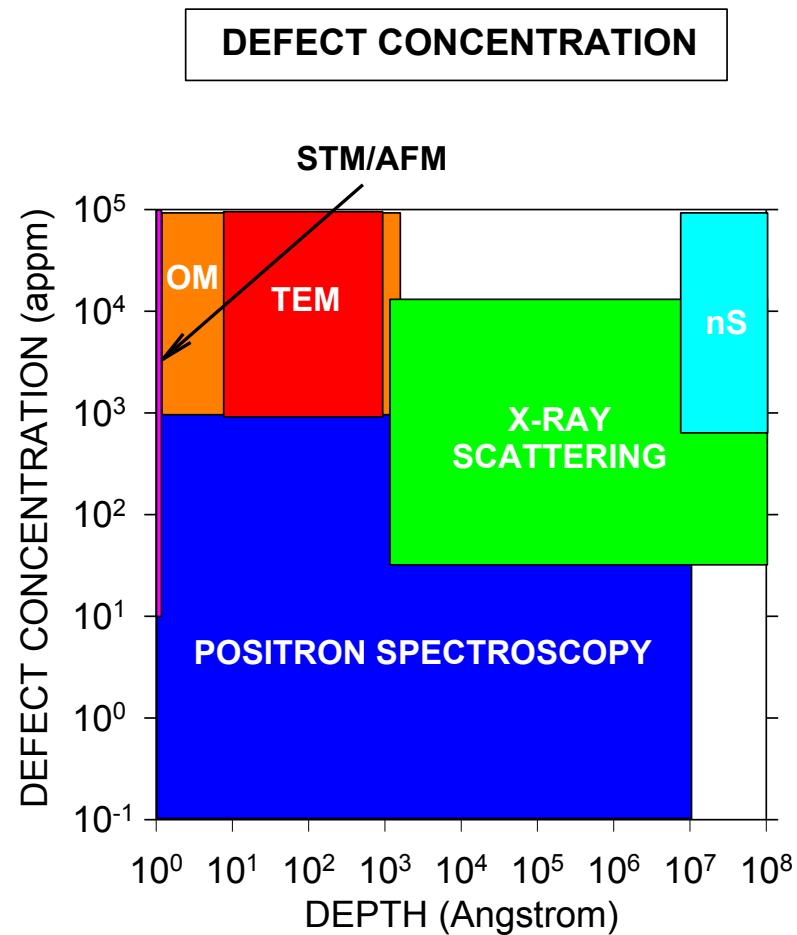
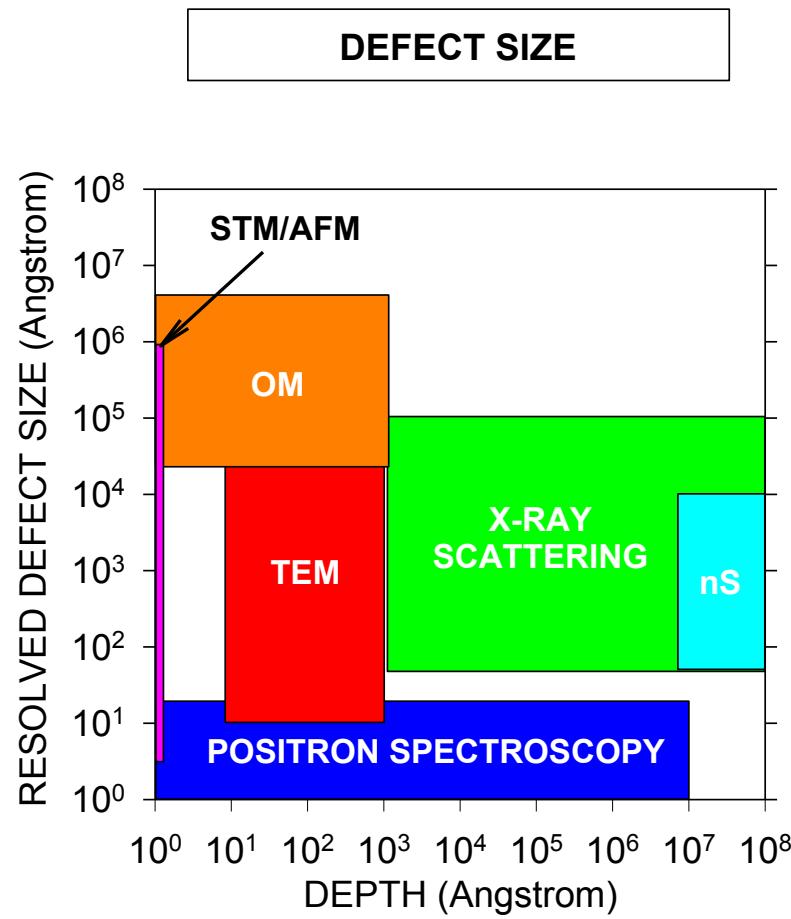
Low C, large traps: $K = 4\pi r DC$

NEUTRAL VACANCY: no detrapping, $\tau > \tau_{\text{bulk}}$, less Doppler broadening: no temperature dependence

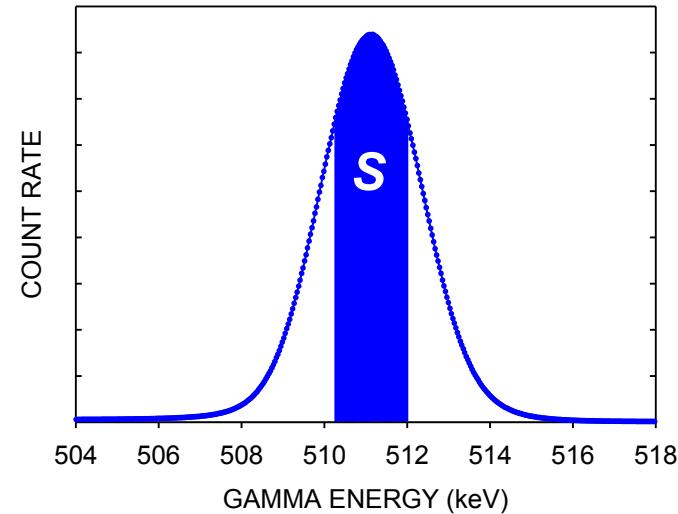
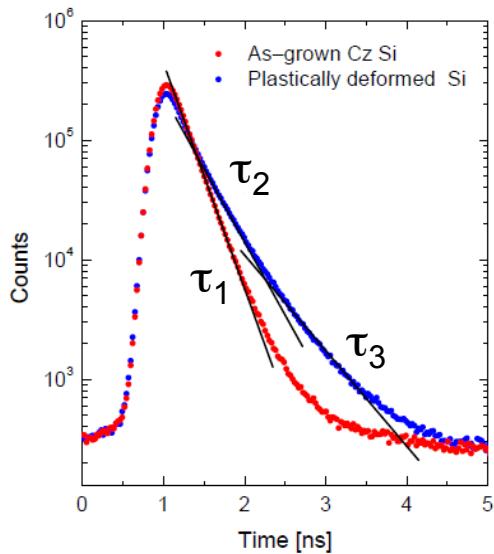
NEGATIVE VACANCY: no detrapping, $\tau > \tau_{\text{bulk}}$, less Doppler broadening: stronger trap at lower temperatures

SHALLOW TRAP (eg NEGATIVE ION): detrapping below 300K, $\tau \sim \tau_{\text{bulk}}$, little Doppler broadening

SENSITIVITY TO OPEN-VOLUME POINT DEFECTS



OPEN-VOLUME POINT DEFECTS: EXTRACTING CONCENTRATIONS



$$N(t) = \sum_i I_i \lambda_i \exp(-\lambda_i t)$$

for two states - bulk or defect:

$$\kappa_d = vC_d = \frac{I_d}{I_b} (\lambda_b - \lambda_d)$$

$$S = \sum_i f_i S_i$$

for two states - bulk or defect:

$$f_D = \frac{S - S_B}{S_D - S_B} = \frac{vC}{vC + \lambda_B}$$

v is the specific trapping rate

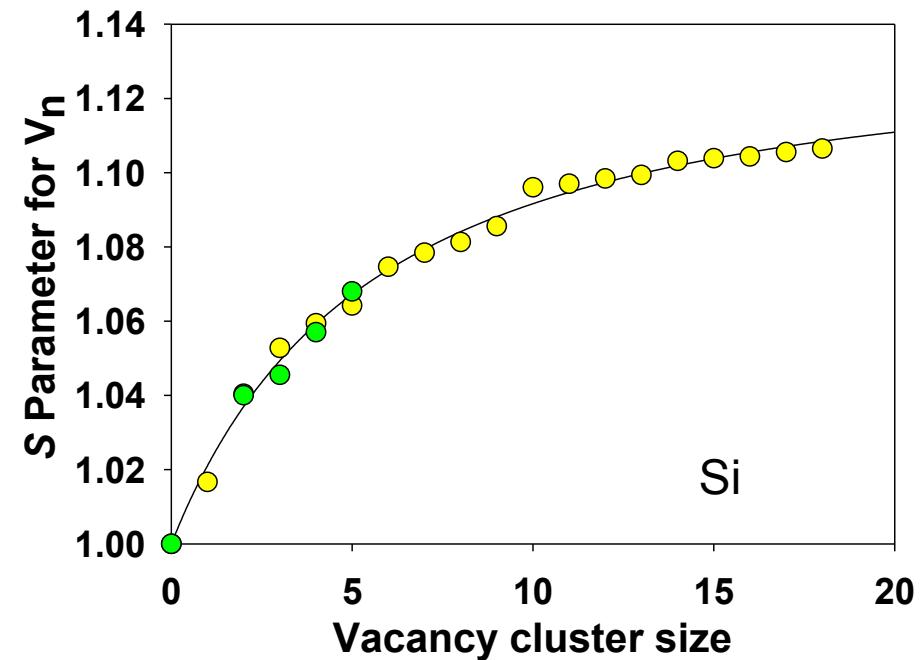
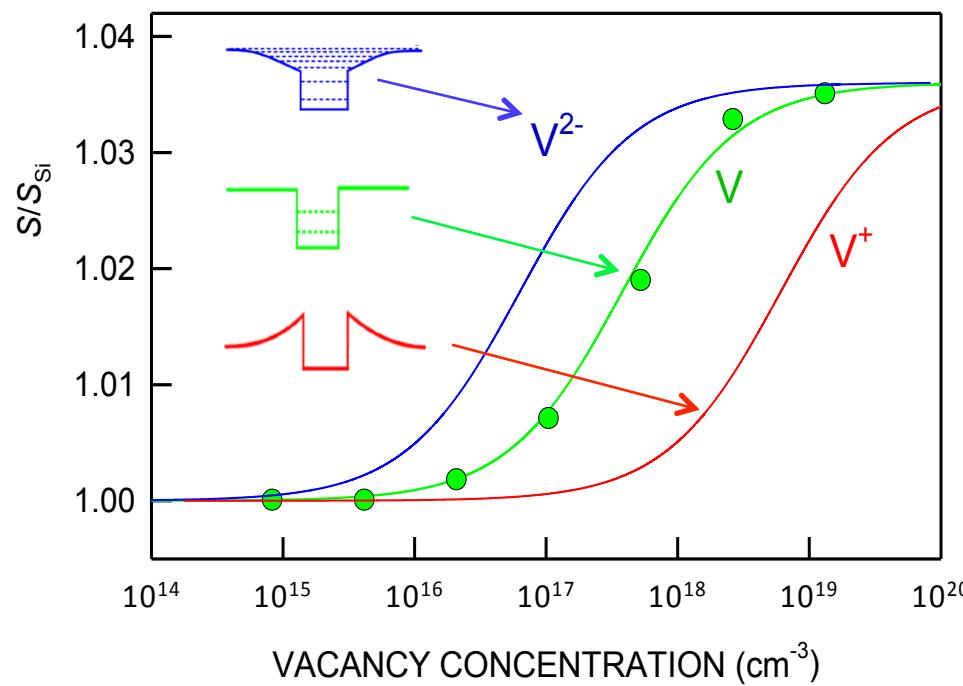
OPEN-VOLUME POINT DEFECTS

CONCENTRATION

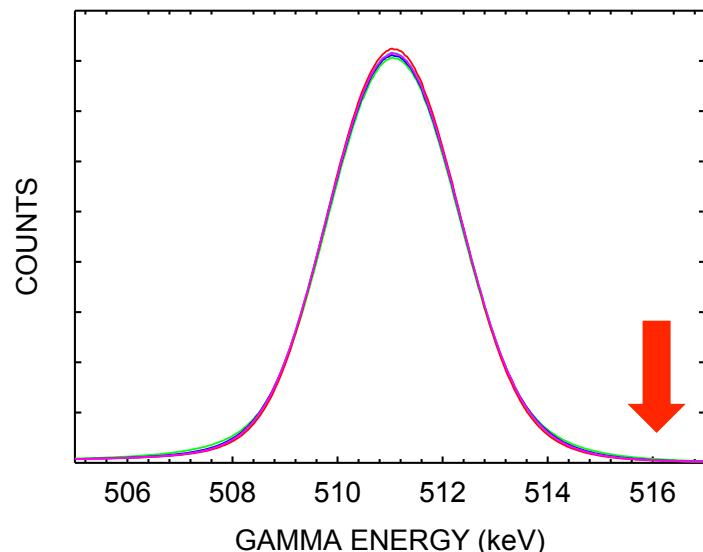
SIZE

ν is the specific trapping rate –
 ν depends on charge state of the defect

τ and S are related to open volume of defect

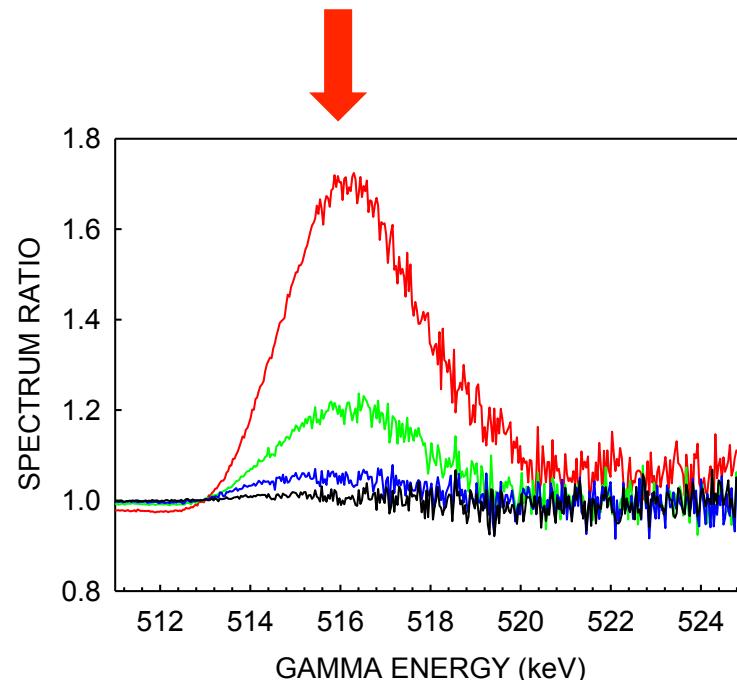


CHEMICAL SPECIFICITY - ANNIHILATION LINESHAPE ANALYSIS



annihilation lines for

- Si
- Ge
- $\text{Si}_{0.7}\text{Ge}_{0.3}$
- $\text{Si}_{0.9}\text{Ge}_{0.1}$
- $\text{Si}_{0.98}\text{Ge}_{0.02}$



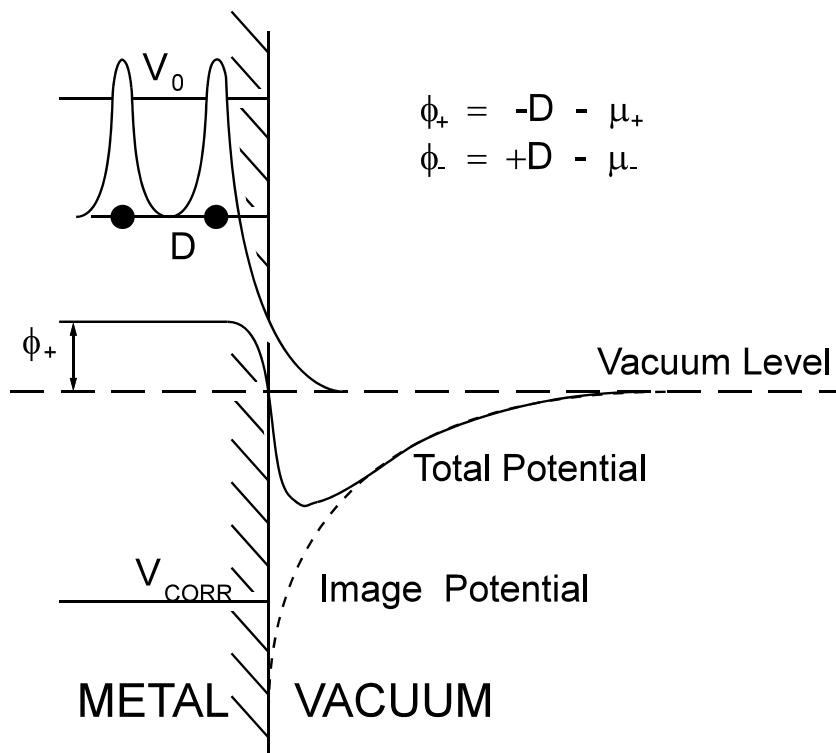
spectrum ratios:

- Ge/Si
- $\text{Si}_{0.7}\text{Ge}_{0.3}/\text{Si} = 30\% \text{ of Ge/Si}$
- $\text{Si}_{0.9}\text{Ge}_{0.1}/\text{Si} = 10\% \text{ of Ge/Si}$
- $\text{Si}_{0.98}\text{Ge}_{0.02}/\text{Si} = 2\% \text{ of Ge/Si}$

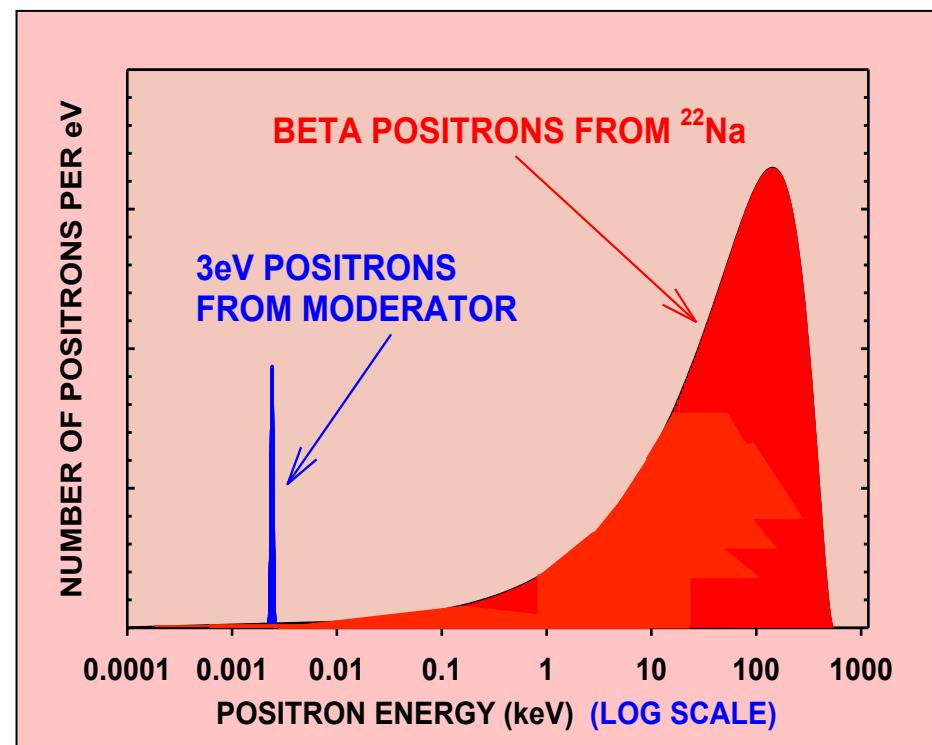
information on chemical environment and affinity

POSITRON MODERATION

NEGATIVE WORK FUNCTION



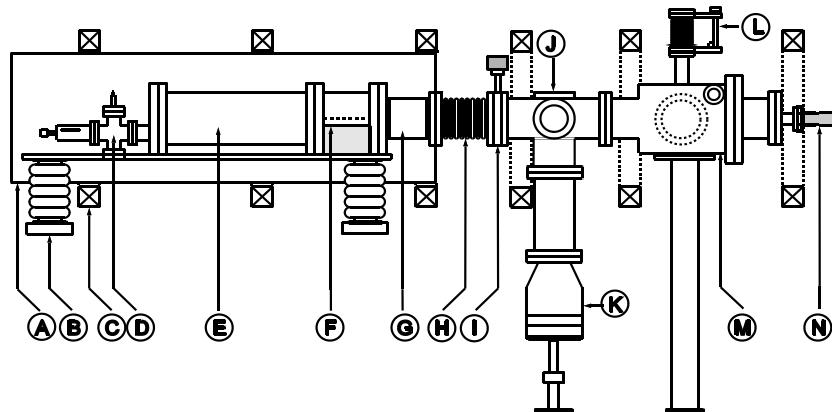
BETA SPECTRUM (0 – 540 keV, PEAK 180 keV)
RE-EMITTED POSITRONS (0 – 3eV, PEAK 1.5eV)



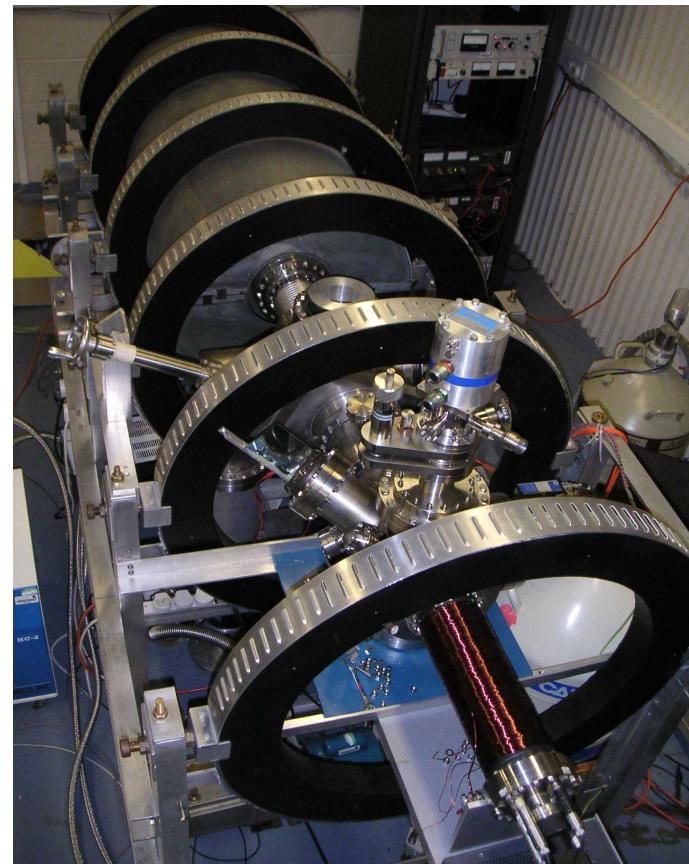
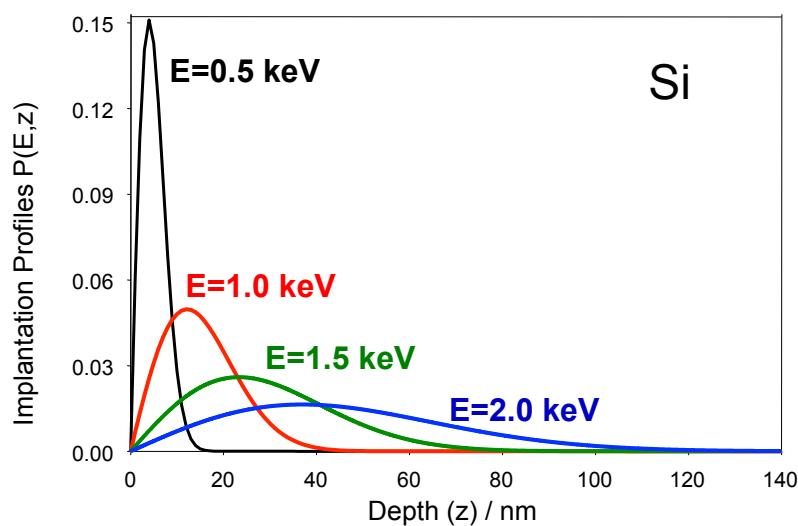
EMISSION FROM TUNGSTEN

alternatives include moderation by solid rare gases

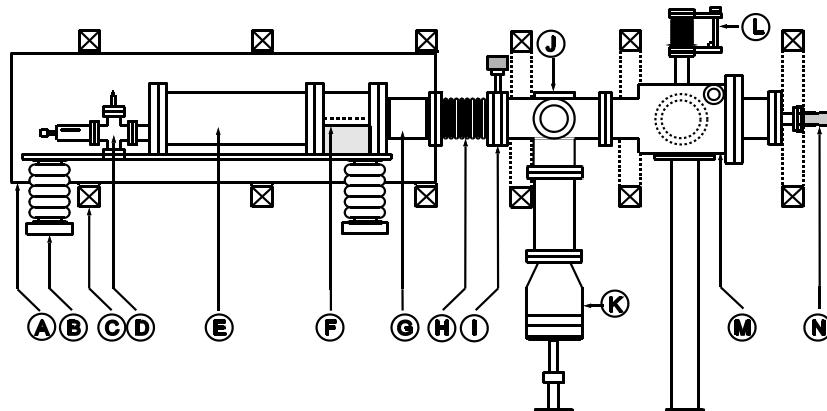
LAB-BASED POSITRON BEAMS



Magnetic-transport positron beam system

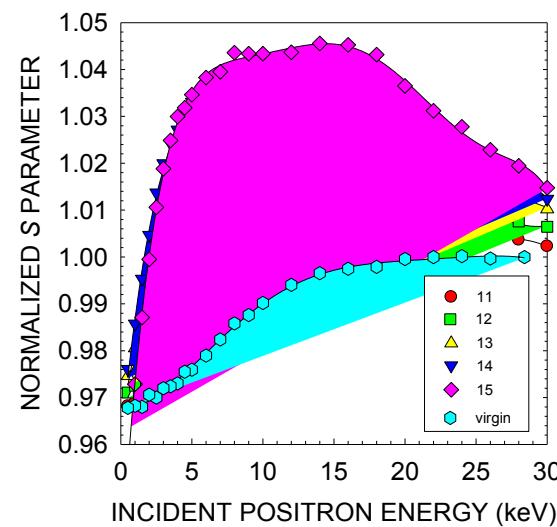


LAB-BASED POSITRON BEAMS

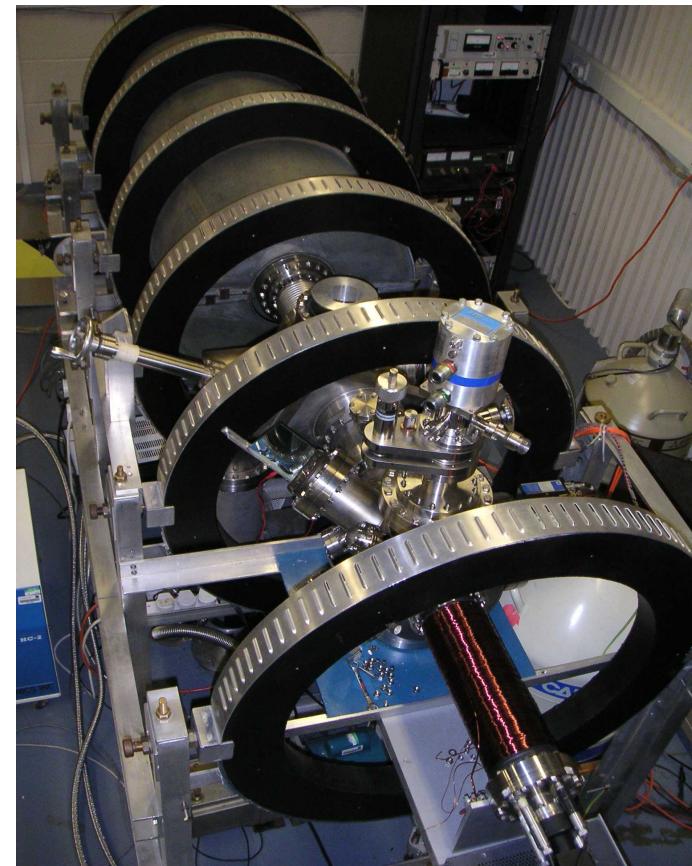


Magnetic-transport positron beam system

FZ Si
implanted
with 2MeV
Si⁺ ions at
 10^n cm^{-2} ($n = 0, 11, 12, 13, 14, 15$)



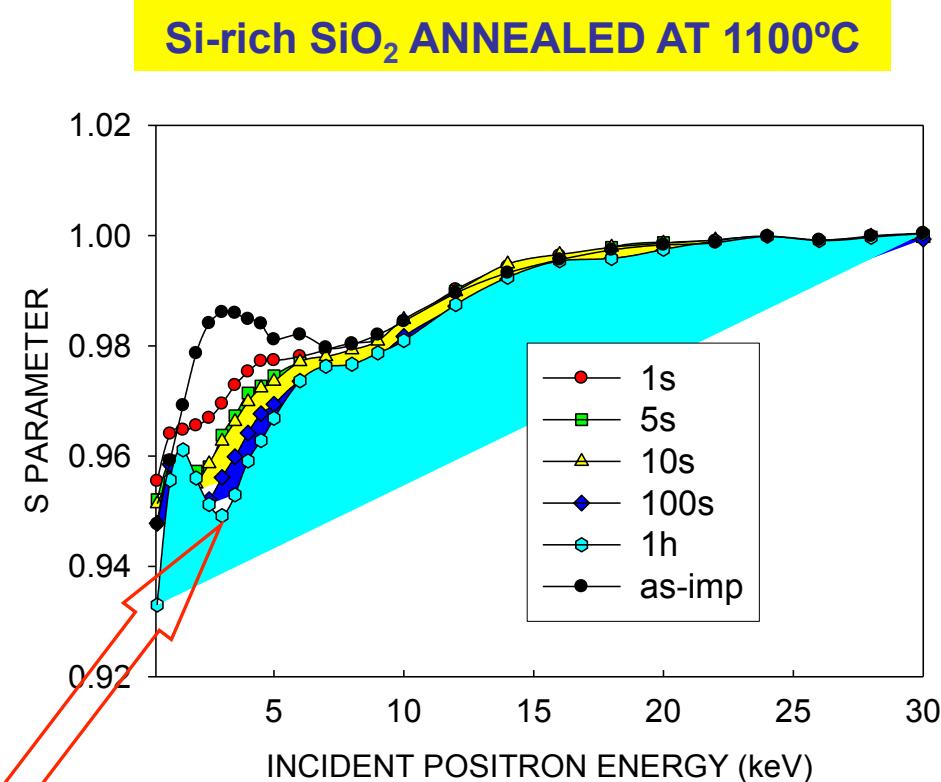
depth sensitivity



also:
TRAP-BASED BEAMS
PULSED BEAMS

EXAMPLES OF POSITRON BEAM STUDIES OF SOLIDS

1. SILICON NANOCRYSTALS in SiO_2 MATRIX

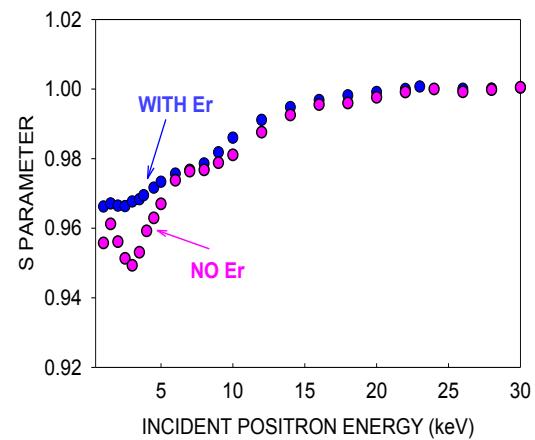
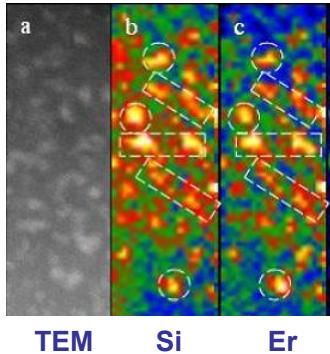


EXAMPLES OF POSITRON BEAM STUDIES OF SOLIDS

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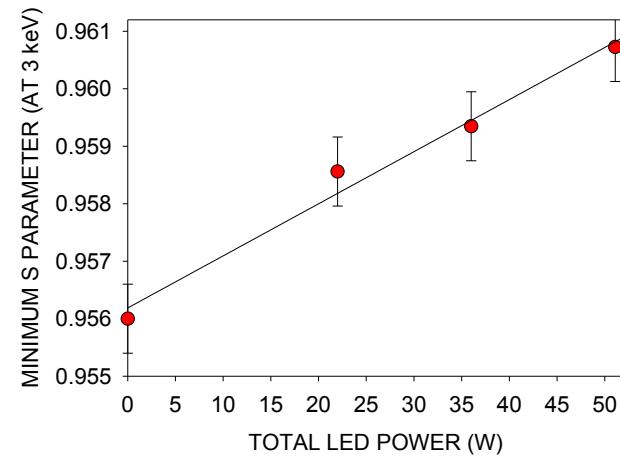
ERBIUM and nSi

3-5nm
clusters –
Er and Si
EELS
responses
coincident



→ Er in interfaces

ILLUMINATION BY BLUE LEDs



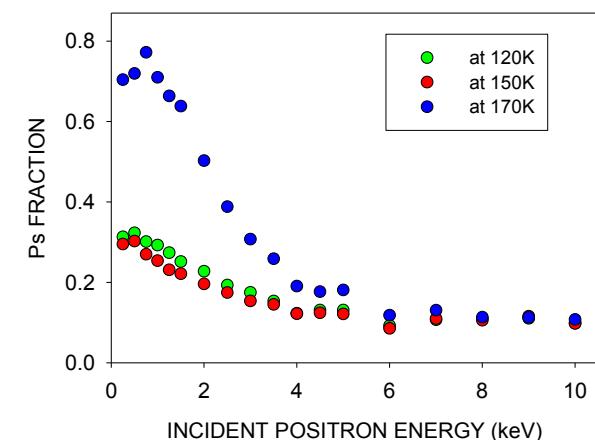
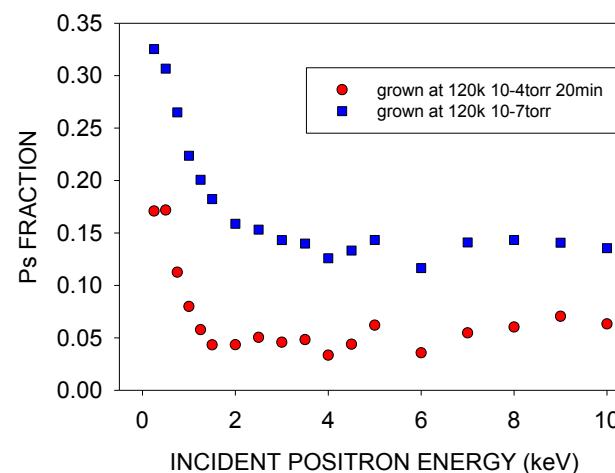
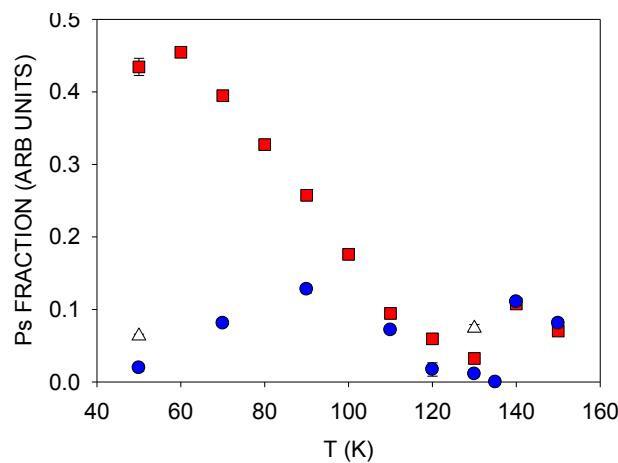
EXAMPLES OF POSITRON BEAM STUDIES OF SOLIDS

2. NANOPORES in ICE

**CLOSED nm
PORES:
Ps DECAY TO 3γ
and Ps LIFETIME
DEPEND ON PORE
SIZE**



**INTERCONNECTED
PORES:
ESCAPE POSSIBLE,
 3γ FRACTION
INCREASED,
VACUUM LIFETIME**



**PORE
COLLAPSE**

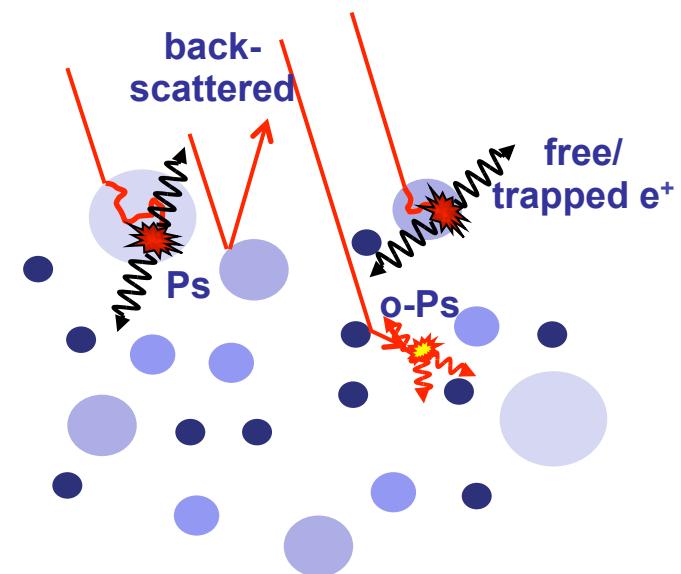
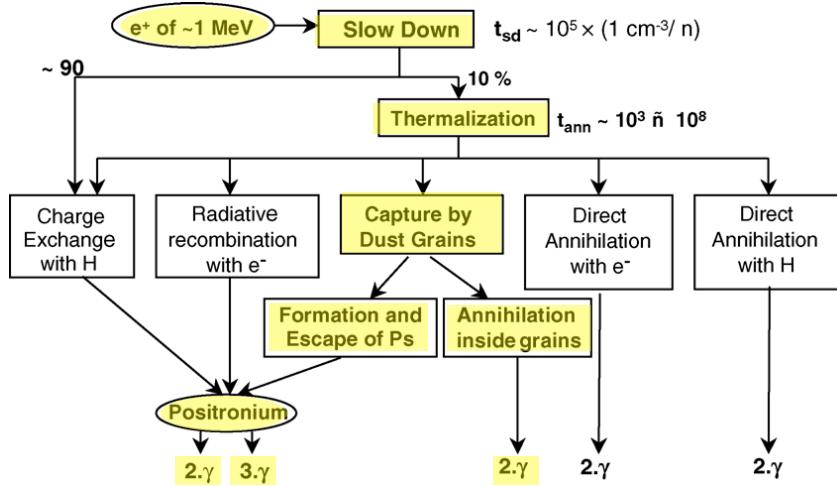
**DEPENDENCE ON
GROWTH RATE**

**DURING
SUBLIMATION**

see poster for more information

POSITRON BEAMS: APPLICATIONS IN ASTROPHYSICS

DUST in the ISM



N. Guessoum, P. Jean & W. Gillard
 Applied Surface Science 252 (2006) 3352

POSITRON BEAMS: APPLICATIONS IN ASTROPHYSICS

DUST in the ISM

DOPPLER BROADENING – CHEMICAL ANALYSIS

DOPPLER BROADENING – STRUCTURAL ANALYSIS

Ps FORMATION AND DECAY – PORES AND STRUCTURAL ANALYSIS

IN-FLIGHT ANNIHILATION ON MODEL SYSTEMS

POSITRON BEAMS:
APPLICATIONS IN ASTROPHYSICS



Thanks to past and present members of the Bath positron group
- and to you for your attention

